

MOSFET – N-Channel, POWERTRENCH®

40 V, 20 A, 5.8 mΩ

FDMC8462

General Description

This N-Channel MOSFET is produced using **onsemi**'s advanced POWERTRENCH process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

Features

- Max $r_{DS(on)} = 5.8 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 13.5 \text{ A}$ Max $r_{DS(on)} = 8.0 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 11.8 \text{ A}$
- Low Profile 1 mm Max in Power 33
- 100% UIL Tested
- Pb-Free, Halide Free and RoHS Compliant

Applications

• DC - DC Conversion

ABSOLUTE MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

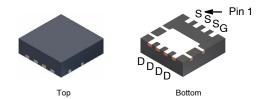
Symbol	Parameter	Value	Unit
V_{DS}	Drain to Source Voltage	40	V
V_{GS}	Gate to Source Voltage	±20	V
I _D	$ \begin{array}{llllllllllllllllllllllllllllllllllll$	20 64 14 50	A
E _{AS}	Single Pulse Avalanche Energy (Note 3)	216	mJ
P _D	$\begin{array}{ll} \mbox{Power Dissipation} & \mbox{T_C = 25°C} \\ \mbox{Power Dissipation (Note 1a)} & \mbox{T_A = 25°C} \end{array}$	41 2.0	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range	–55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS ($T_A = 25^{\circ}C$ unless otherwise noted)

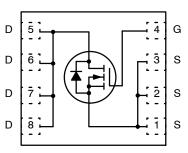
Symbol	Parameter	Value	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case	3	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	°C/W

V _{DS}	r _{DS(ON)} MAX	I _D MAX
40 V	5.8 mΩ @ 10 V	20 A
	8.0 mΩ @ 4.5 V	



PQFN8 3.3 × 3.3, 0.65P (Power 33) CASE 483AK

ELECTRICAL CONNECTION



N-Channel MOSFET

MARKING DIAGRAM

ZXYYKK FDMC 8462

Z = Assembly Plant Code

XYY = 3-Digit Date Code (Year and Week) KK = 2-Digits Lot Run Traceability Code

FDMC8462 = Specific Device Code

ORDERING INFORMATION

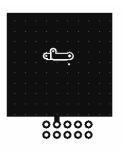
See detailed ordering and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHAR	ACTERISTICS		•		•	
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	40	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C	-	31	-	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{GS} = 0 V, V _{DS} = 32 V	-	-	1	μА
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±20 V, V _{DS} = 0 V	-	_	±100	nA
ON CHARA	CTERISTICS					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.0	2.0	3.0	٧
$\frac{\Delta V_{GS(th)}}{\Delta T_{J}}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C	_	-6.6	-	mV/°C
r _{DS(on)}	Static Drain to Source On–Resistance	V _{GS} = 10 V, I _D = 13.5 A V _{GS} = 4.5 V, I _D = 11.8 A V _{GS} = 10 V, I _D = 13.5 A, T _J = 125°C	- - -	4.7 6.4 7.1	5.8 8.0 9.3	mΩ
g _{FS}	Forward Transconductance	V _{DD} = 5 V, I _D = 13.5 A	_	60	-	S
DYNAMIC (CHARACTERISTICS			_		
C _{iss}	Input Capacitance	V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHz	_	2000	2660	pF
C _{oss}	Output Capacitance		_	545	725	pF
C _{rss}	Reverse Transfer Capacitance		_	80	120	pF
R_{g}	Gate Resistance	f = 1 MHz	-	2.7	-	Ω
SWITCHING	G CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	V _{DD} = 20 V, I _D = 13.5 A,	_	12	21	ns
t _r	Rise Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	_	4	10	ns
t _{d(off)}	Turn-Off Delay Time		_	27	43	ns
t _f	Fall Time		-	3	10	ns
Q_g	Total Gate Charge	V_{GS} = 0 V to 10 V, V_{DD} = 20 V, I_D = 13.5 A	-	30	43	nC
		V_{GS} = 0 V to 4.5 V, V_{DD} = 20 V, I_D = 13.5 A	-	15	21	nC
Q_gs	Gate to Source Charge	V _{DD} = 20 V, I _D = 13.5 A	_	6	-	nC
Q_{gd}	Gate to Drain "Miller" Charge		-	5	_	nC
DRAIN-SO	URCE DIODE CHARACTERISTICS					
V_{SD}	Source to Drain Diode Forward	V _{GS} = 0 V, I _S = 13.5 A (Note 2)	_	0.8	1.3	V
	Voltage	V _{GS} = 0 V, I _S = 1.7 A (Note 2)	-	0.7	1.2	
t _{rr}	Reverse Recovery Time	I _F = 13.5 A, di/dt = 100 A/μs	_	35	57	ns
Q _{rr}	Reverse Recovery Charge		_	20	32	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. $R_{\theta JA}$ is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 53°C/W when mounted on a 1 in² pad of 2 oz copper

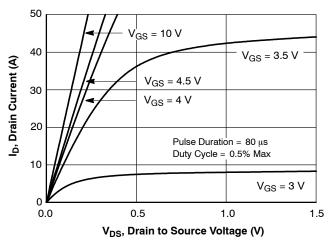


b) 125°C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%. 3. Starting T_J = 25°C; N-ch: L = 3 mH, I_{AS} = 12 A, V_{DD} = 40 V, V_{GS} = 10 V.

TYPICAL CHARACTERISTICS

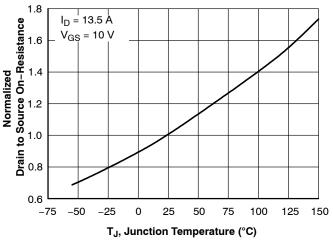
 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$



5.0 Pulse Duration = 80 μs 4.5 Duty Cycle = 0.5% Max $V_{GS} = 3 V$ to Source On-Resistance 4.0 Normalized Drain 3.5 3.0 $V_{GS} = 3.5 V$ 2.5 2.0 V_{GS} = 4 V 1.5 1.0 V_{GS} = 4.5 V $\dot{V_{GS}} = 10 \text{ V}$ 0.5 0 10 20 ID, Drain Current (A)

Figure 1. On-Region Characteristics

Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage



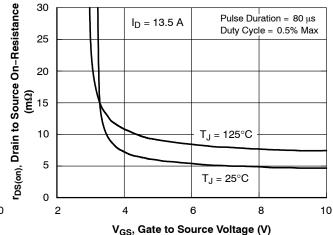
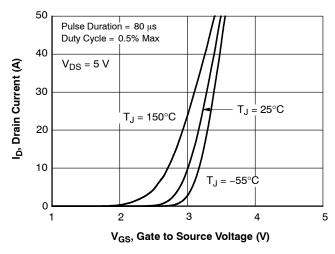


Figure 3. Normalized On–Resistance vs. Junction Temperature

Figure 4. On-Resistance vs. Gate to Source Voltage



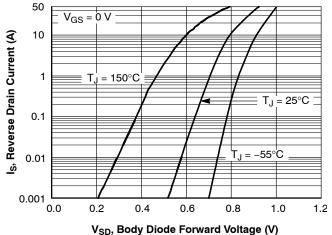
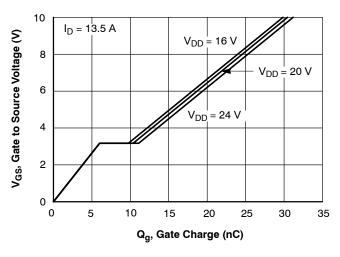


Figure 5. Transfer Characteristics

Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (continued)

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$



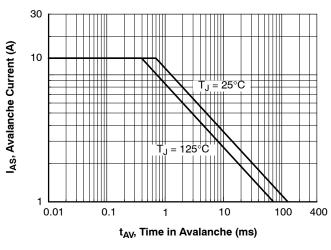
1000

1000

1000 f = 1 MHz $V_{GS} = 0 \text{ V}$ 1000 V_{DS} , Drain to Source Voltage (V)

Figure 7. Gate Charge Characteristics

Figure 8. Capacitance vs. Drain to Source Voltage



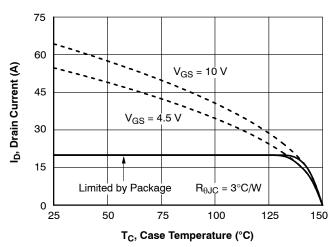
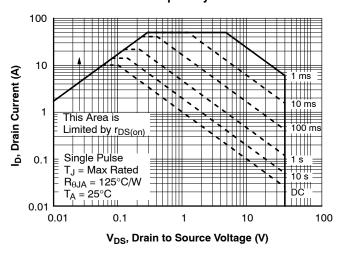


Figure 9. Unclamped Inductive Switching Capability

Figure 10. Maximum Continuous Drain Current vs Case Temperature



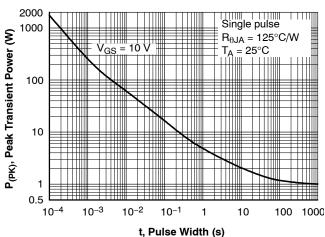


Figure 11. Forward Bias Safe Operating Area

Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (continued)

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

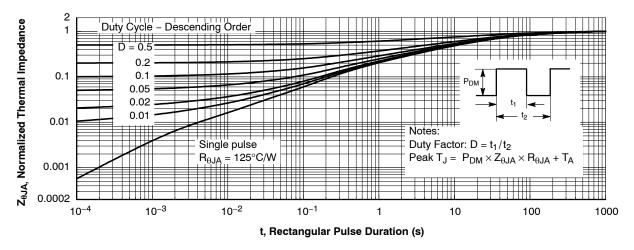


Figure 13. Transient Thermal Response Curve

PACKAGE MARKING AND ORDERING INFORMATION

Device	Device Marking	Package Type	Reel Size	Tape Width	Shipping [†]
FDMC8462	FDMC8462	PQFN8 3.3 x 3.3, 0.65P (Power 33) (Pb-Free/Halide Free)	13"	12 mm	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

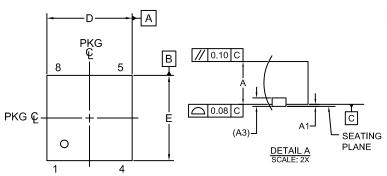
POWERTRENCH is a registered trademark of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries.





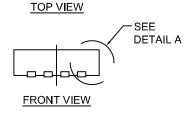
PQFN8 3.3X3.3, 0.65P CASE 483AK **ISSUE B**

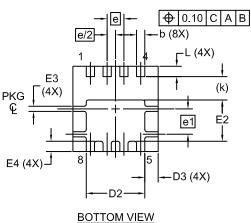
DATE 12 OCT 2021

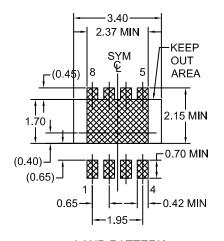


NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION. MILLIMETERS
- COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
- 6. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.







LAND PATTERN RECOMMENDATION

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

DIM	MILLIMETERS				
Diii.	MIN.	NOM.	MAX.		
Α	0.90	1.00	1.10		
A1	0.00	-	0.05		
A3	(0.20 REF			
b	0.27	0.32	0.37		
D	3.20	3.30	3.40		
D2	2.17	2.27	2.37		
D3	0.42	0.52	0.62		
Е	3.20	3.30	3.40		
E2	1.50	1.70			
E3	0.10	0.20	0.30		
E4	0.29	0.39	0.49		
е	0.65 BSC				
e/2	0.325 BSC				
e1	0.98 BSC				
k	0.91 REF				
L	0.30	0.40	0.50		
		•			

DOCUMENT NUMBER:	98AON13660G	Electronic versions are uncontrolled except when accessed directly from the Document Repositor Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	PQFN8 3.3X3.3, 0.65P		PAGE 1 OF 1	

onsemi and ONSEMI are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. **onsemi** does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer pu

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT: Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative